

Mycelium Temporal Memory Analysis Report

EXPERIMENT OVERVIEW

Date & Time: 2026-02-20 17:40:10
Report Generated: mycelium_memory_analysis_report_20260220_174010.pdf

TEST CONFIGURATION

Test Type: Sine Wave Test
Sample Delay: 300 ms (0.3 seconds per sample)
Test Duration Setting: 60 seconds
Actual Test Duration: 60.0 seconds
Input Amplitude: 4.0 V (voltage range applied to mycelium)
Max Correlation Lag: 10 samples (3.0 seconds lookback)
Total Data Points: 200 samples

DATA COLLECTION SUMMARY

Input Voltage Range: 1.20V to 4.00V
State Voltage Range: 0.257V to 0.279V
State Voltage Mean: 0.265V \pm 0.004V
Data Quality: ✓ Good

HARDWARE CONFIGURATION

Device Mode: Real Hardware
Input Device: Digilent Device 1
Measurement Device: Digilent Device 2

Temporal Memory Analysis Results

TEMPORAL MEMORY ANALYSIS RESULTS

AUTOCORRELATION ANALYSIS

Maximum Correlation: 0.5136
Optimal Lag: 4 samples (1.2 seconds)
Memory Persistence: Strong
Interpretation: States show strong self-similarity over time

CROSS-CORRELATION ANALYSIS

Maximum Input-State Correlation: 0.2769
Optimal Lag: 1 samples (0.3 seconds)
Input Memory Effect: Moderate
Interpretation: Past inputs moderately influence current states

STATE PREDICTION ANALYSIS

Current Input Only R^2 : 0.0767
With Input History R^2 : 0.1399
Temporal Improvement: 0.0632
Temporal Benefit: Moderate
Interpretation: Input history moderately improves prediction

RESPONSE DECAY ANALYSIS

Status: Response decay analysis requires Step Response Test

OVERALL MEMORY ASSESSMENT

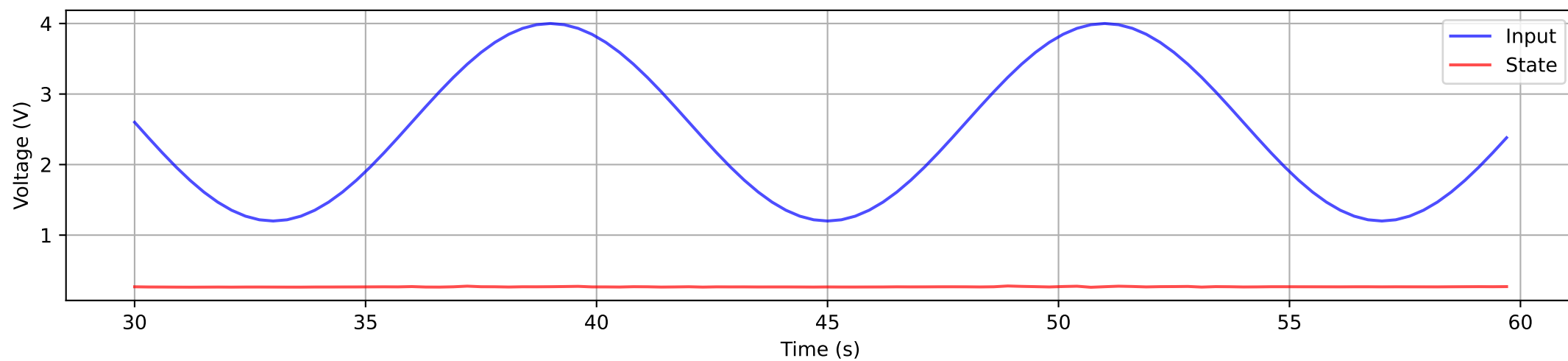
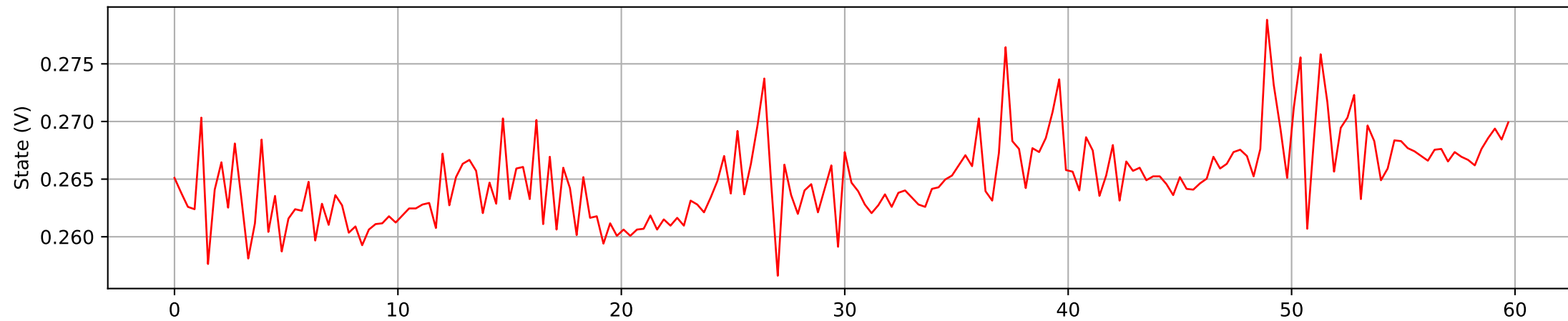
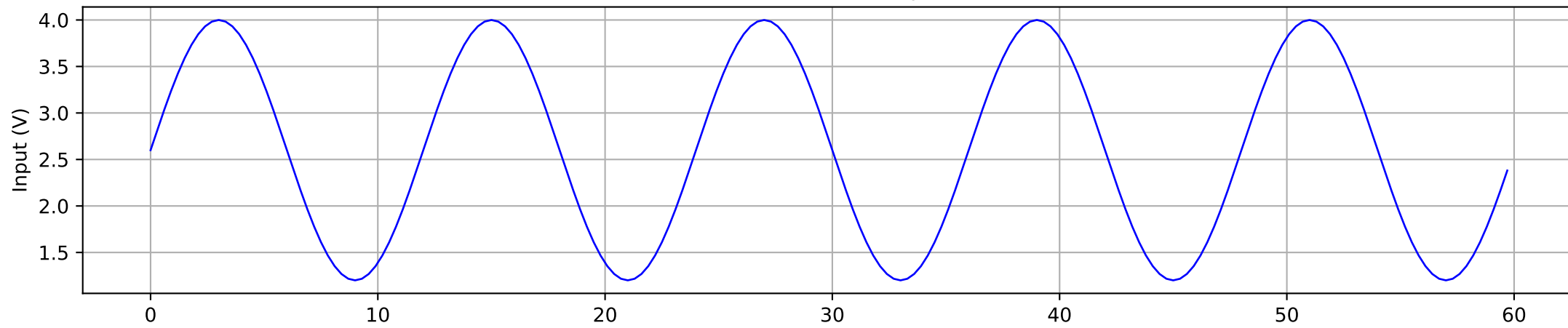
Memory Score: 3/3
★★★

CONCLUSION: ☐ Strong evidence of temporal memory effects

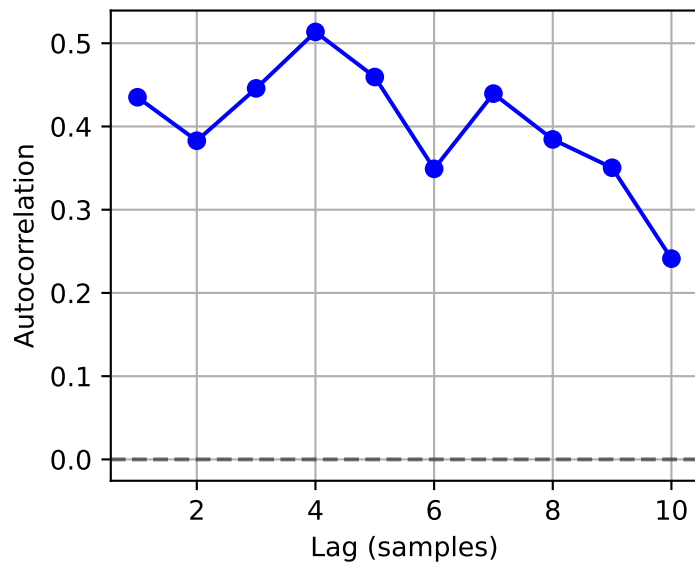
RESERVOIR COMPUTING ASSESSMENT:

✓ This mycelium sample shows excellent reservoir computing potential

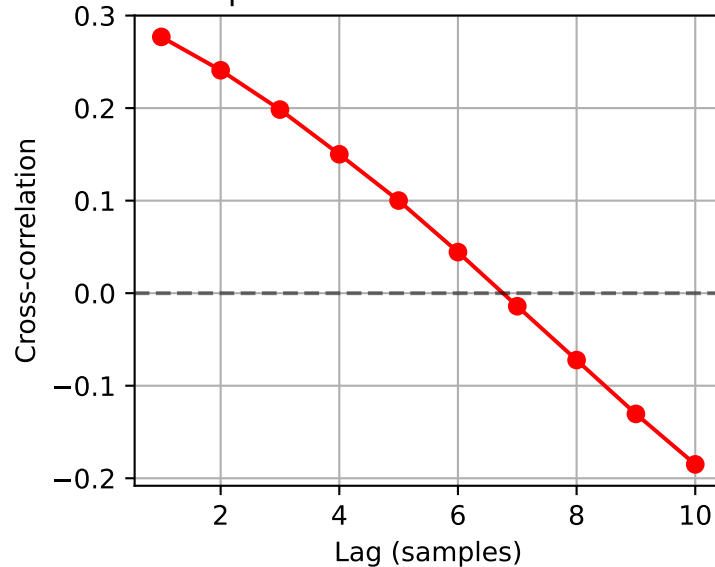
Sine Wave Test - Sample 200



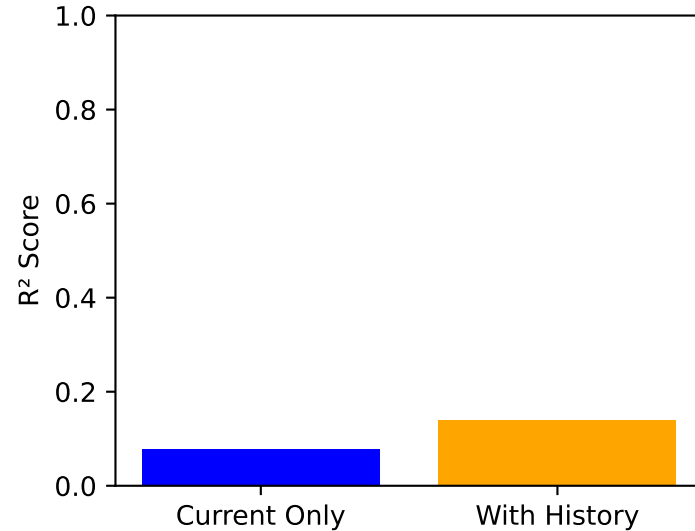
State Autocorrelation



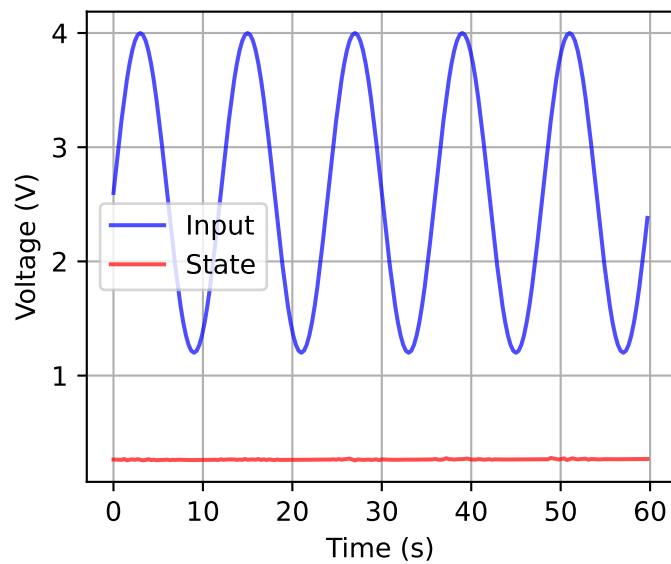
Input-State Cross-correlation



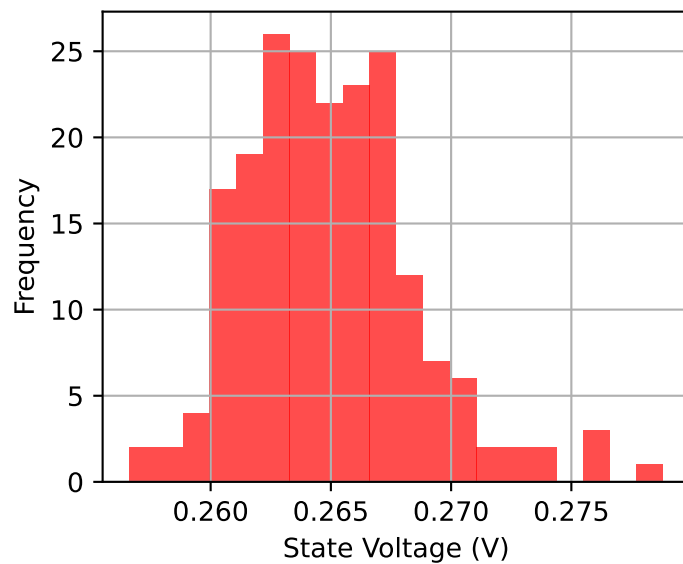
Prediction Performance



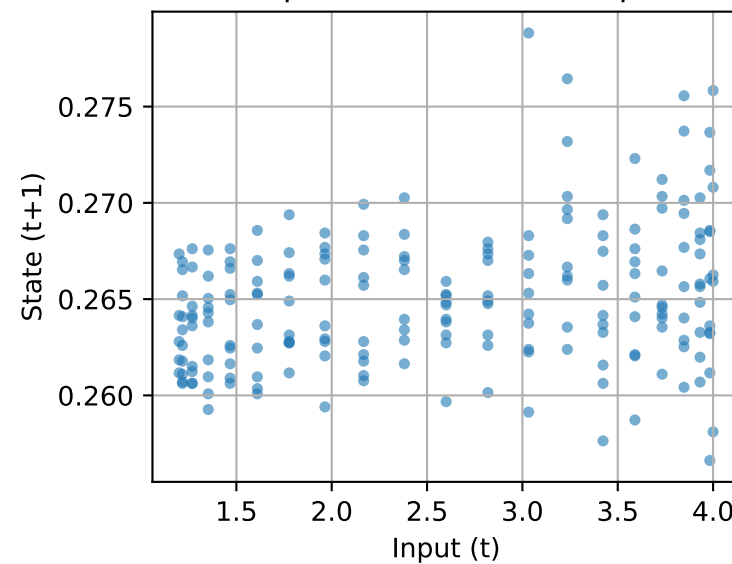
Full Time Series



State Distribution



Input-State Relationship



Data Summary Tables

Parameter	Input (V)	State (V)
Mean	2.600	0.265
Std Dev	0.990	0.004
Min	1.200	0.257
Max	4.000	0.279
Range	2.800	0.022

Lag (samples)	Lag (seconds)	Autocorr	Cross-corr
1	0.3	0.435	0.277
2	0.6	0.383	0.241
3	0.9	0.446	0.198
4	1.2	0.514	0.150
5	1.5	0.459	0.100
6	1.8	0.349	0.044
7	2.1	0.439	-0.014
8	2.4	0.384	-0.072
9	2.7	0.350	-0.130
10	3.0	0.241	-0.185